Sheet	1	of 1

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 117625			APPLICATION NO. 10/717,596			
(Use several sheets if necessary)										
JAN 3 1 7006 B					APPLICANT(S) Ayae ENDO et al.					
U.S. PATEN			FILING DATE November 21, 2003			GROUP 1774				
U.S. PATENT DOCUMENTS										
Examiner Initials	Cite No.	Document Number	Da	te	Na	Name				
			L							
			L							
FOREIGN PATENT DOCUMENTS										
Examiner Initials	Cite No.	Document Number	Date		Country		With English Abstract	With English Translation		
Des	1.	JP 2002-184583 A	6-28-200	2	JAPAN		x	х		
PS	2.	JP 07-135079 A 5-23-19		5	JAPAN		x	х		
D's	3.	JP 2602888 B	10-13-1989		JAPAN			х		
BA	4.	JP 06-110054 A	4-22-1994		JAPAN		x	х		
Q9J	5.	JP 05-173124 A	7-13-1993		JAPAN		х	х		
Ø80	6.	JP 2001-291587 A	10-19-2001		JAPAN		х	х		
QPA.	7.	JP 2001-225440 A	8-21-2001		JAPAN		х	x		
Des	8.	JP 2001-260307 A	9-25-2001		JAPAN		x	x		
294	9.	JP 2001-315293 A	11-13-20	001	JAPAN		х	×		
			OTHER D							
Examiner Initials	Cite No.	(Including Aut	hor, Title, l	Date, Perti	nent Pages, etc.)					
· · · · · · · · · · · · · · · · · · ·										
EXAMINER	AMINER Daune Samett Date considered 4/6/2006									
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.										

Date: January 31, 2006